



Approved Method: **Electrical and Photometric Measurements of Single-Based Fluorescent Lamps**

**IES Approved Method
for the
Electrical and Photometric Measurements of
Single-Based Fluorescent Lamps**

**Prepared by the Subcommittee on
The Subcommittee on Photometry of Light Sources
of the IES Testing Procedures Committee**

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Contents

Foreword	1
Introduction	1
1.0 Scope	2
2.0 Normative References	2
3.0 Definitions	2
3.1 Amalgam	2
3.2 Cold Chamber or Cold Spot	2
4.0 Ambient and Physical Conditions	2
4.1 General	2
4.2 Vibration	3
4.3 Temperature	3
4.4 Air Movement	3
4.5 Operating Orientation	3
5.0 Power Source Characteristics	3
5.1 Power Supply Requirements	3
5.1.1 Voltage Waveshape	3
5.1.2 Voltage Regulation	3
5.1.3 Power Supply Impedance	3
5.2 Auxiliary equipment	3
5.2.1 Reference Circuit Requirements	3
5.2.2 Circuits for High Frequency Operation of lamps with electrodes	4
5.2.2.1 Preheat Start Lamps, Non-Integrated, Line Frequency	4
5.2.2.2 Rapid Start Lamps, Non-Integrated, Line Frequency	4
5.2.2.3 Instant Start Lamps, Non-Integrated, Line frequency	5
5.2.3 Integrated Compact Fluorescent Lamp and Integrated Electrodeless Fluorescent Lamps	6
5.2.4 Starters	6
5.3 Electrical Instrumentation	6
5.3.1 Frequency Response	6
5.3.2 Impedance Limitations	7
5.3.3 Instrument Tolerance/Uncertainty	7
6.0 Testing Procedures Requirements	7
6.1 Preparation for Test	7
6.1.1 Marking and Handling Requirements	7
6.1.2 Seasoning	7
6.1.3 Preburn	7
6.1.4 Transfer of Lamp to the Measurement Circuit	7

